



# Study of radiation-hard semiconductor materials and radiation sensors for future colliders

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## Researchers

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- prof. V. Tamošiūnas
- dr. V. Rumbauskas
- dr. J. Pavlov,
- dr. L. Deveikis
- dr. A. Mekys),
- Phd students – 1 (Ž. Vosylius),
- BC. students – 5
- Ms. students – 1.

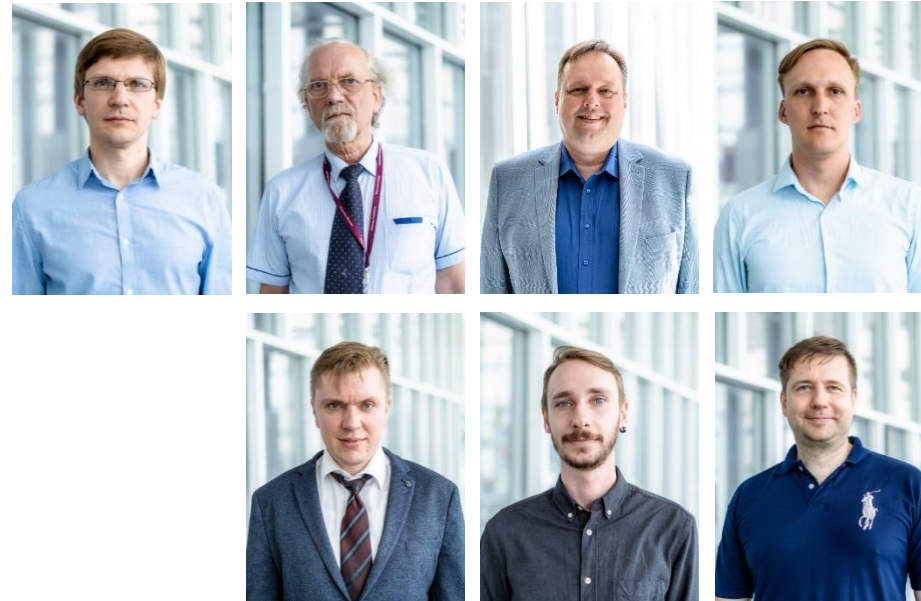
### Fotonikos ir nanotechnologijų institutas

- ▼ FNI
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- > Publikacijos
- > Finansavimas
- > Tyrimų grupės
- > Darbuotojai
- > Studentams
- > Kontaktai

### FNI



### Fotonikos ir nanotechnologijų institutas



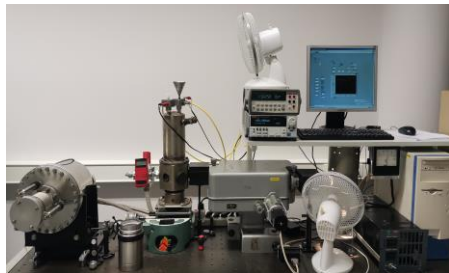
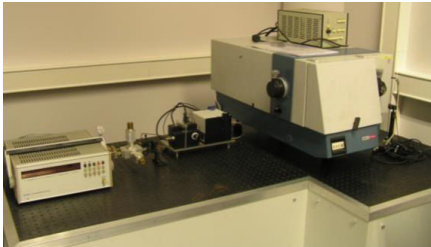


## Major research activities

- Search of radiation hard materials and development of radiation tolerant sensor structures.
- Engineering of defects for development of radiation hard particle and photo sensors.
- Development of technologies and instrumentation for spectroscopy and contactless-remote dosimetry of the large fluences of high energy radiations.
- Development of technologies and instruments for the remote in situ measurements in harsh irradiation environments.
- Development of advanced material characterization techniques and instruments.



## Facilities



- Instrumentation for testing the electric characteristics of radiation detectors
- Instrument for profiling of carrier drift current transients
- Instrumentation for measurement of pulsed barrier capacitance transients (BELIV)
- EPR scanner BRUKER-E-SCAN
- Instrument for pulsed spectroscopy of thermal and photo-ionization VUTEG-6
- Instrument for steady-state photo-ionization spectroscopy
- Instrumentation for simultaneous spectroscopy of time-resolved luminescence and microwave-probed photoconductivity
- DLTS spectrometer HERA-DLTS System FT 1030
- Pulsed photo-ionization spectroscopy



# Activities at CERN

**The CERN Experimental Programme**  
*Grey Book database*

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- Research Programme**
- LHC
  - SPS
  - PS
  - AD
  - ISOLDE Facility
  - Irradiation Facility
  - Neutrino Platform
  - GRADE
  - CTF3
  - R&D
  - [Non-accelerator experiments](#)

- Research Activities**
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  - [Recognized Experiments](#)
  - [Completed Experiments](#)

## RD50

Development of Radiation Hard Semiconductor Devices for Very High Luminosity Colliders

- [Overview](#) [Teams](#) [Participations](#)

**Spokesperson:** CASSE, Gianluigi  
 MOLL, Michael

**Contact person:** MOLL, Michael

**Experimental Safety Officer (EXSO):** COSTANZI, Ruddy Alain

**Experiment secretariat e-mail:** dt-secretariat@cern.ch

**Synonym:**

**Research Programme:** R&D

**Approved:** 30-05-2002

**Beam:**

**Status:** In-Progress



**Number of Institutes:** 66

**Number of Countries:** 25

**Number of Participants:** 238

**Number of Authors:** 191

### Status History

Status	Start Date	End Date
Preparation	30-05-2002	25-01-2004
In-Progress	26-01-2004	



# Activities at CERN

## The CERN Experimental Programme

Grey Book database

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Welcome

Experiments & Projects

Teams

Participations

Countries

### Research Programme

- LHC
- SPS
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- ISOLDE Facility
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- Neutrino Platform
- GRADE
- CTF3
- R&D
- Non-accelerator experiments
- Approved Studies for Future Projects

### Research Activities

- Experiments and Projects under Study
- External Experiments
- Recognized Experiments
- Completed Experiments

## Institute of Photonics and Nanotechnology

Overview

Experiments

Participations

Search criteria:

Search

Name	Experiment Name	Author
Tomas CEPONIS	RD50	N
Laimonas DEVEIKIS	RD50	N
Eugenijus GAUBAS	RD50	Y
Jevgenij PAVLOV	RD50	N
Vytautas RUMBAUSKAS	RD50	N

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# Participation in common R&D projects within RD50 collaboration

## RD50 funding request

Date:  
17.05.2022

**Title of the project:** *Defect engineering in PAD diodes mimicking the gain layer in LGADs*

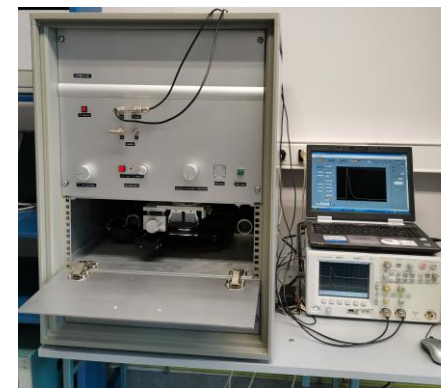
**RD50 Institutes:**

- NIMP, Ioana Pintilie, [ioana@infim.ro](mailto:ioana@infim.ro)
- CERN, Michael Moll, [Michael.moll@cern.ch](mailto:Michael.moll@cern.ch)
- CiS, Kevin Lauer, [klauer@cismst.de](mailto:klauer@cismst.de)
- JSI, Gregor Kramberger, [Gregor.Kramberger@ijs.si](mailto:Gregor.Kramberger@ijs.si)
- HH, Eckhart Fretwurst, [Eckhart.fretwurst@desy.de](mailto:Eckhart.fretwurst@desy.de)
- INFN-Torino, Valentina Sola, [sola.valentina@gmail.com](mailto:sola.valentina@gmail.com)
- Vilnius University, Tomas Ceponis, [tomas.ceponis@ff.vu.lt](mailto:tomas.ceponis@ff.vu.lt)

**Request to RD50:** 26665 EUR

**Total project costs:** 51165 EUR

Project in progress



- In 2022 the VU group joined the project “*Defect engineering in PAD diodes mimicking the gain layer in LGADs*” within the frame of CERN RD50 collaboration.
- The research is important in developing the semiconductor detectors with internal gain for CERN experiments. The VU group is responsible for direct measurements of carrier recombination lifetime and correlation with parameters obtained by electrical measurements in LGAD structures.
- The unique instruments and techniques (developed by VU group) of carrier lifetime profiling and electrical characterization will be employed in this study.



# Participation in common R&D projects within RD50 collaboration

## RD50 Common Project Proposal

### Partial Activation of Boron to enhance the radiation tolerance of the gain implant PAB

V. Sola, Torino University and INFN

#### Abstract

The partial activation of the boron atoms implanted in the gain layer region will be investigated to mitigate the effect of radiation on the gain implant in LGAD sensors [1, 2]. Atoms of boron in the gain layer volume left as interstitials can interact with other impurities present in the silicon lattice, preventing the removal of boron atoms from substitutional positions.

The goal of the project is to investigate the effect of partial activation of boron (PAB) to mitigate the boron removal due to irradiation and to extend by more than a factor of 2 the radiation tolerance of the LGAD sensors.

The groups intend joining common R&D project “Partial activation of boron to enhance the radiation tolerance of the gain implant”.

The VU researches will perform:

- carrier lifetime measurements,
- defect spectroscopy,
- electrical characterization.

Project under preparation.





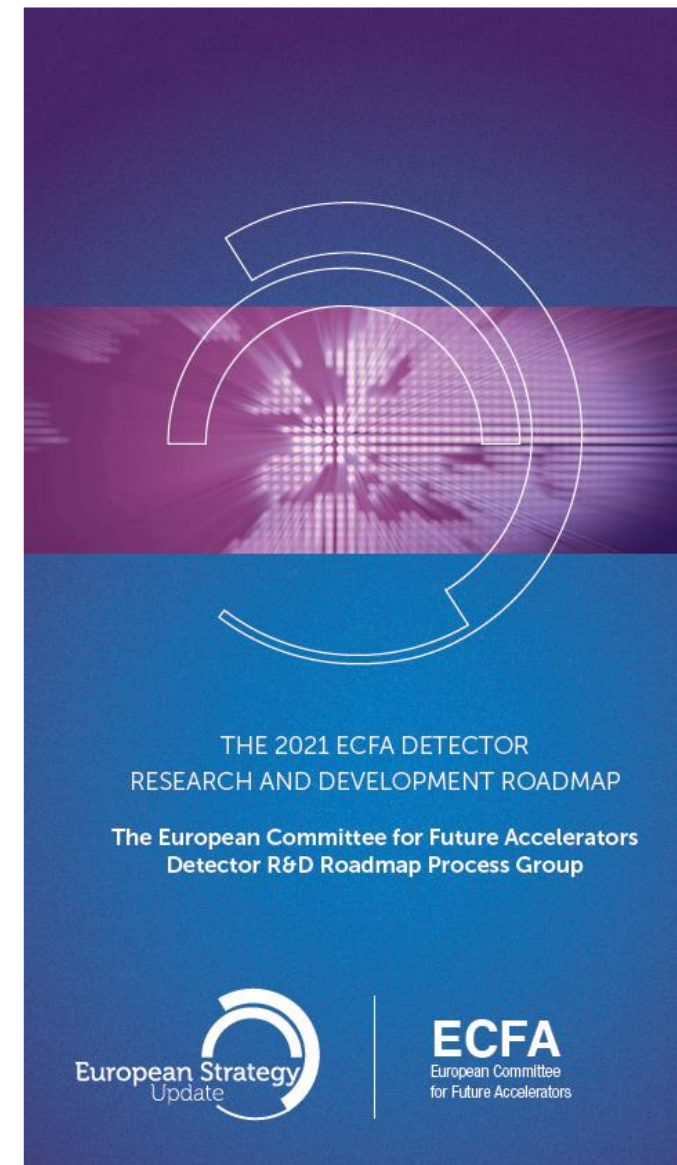
# Transfer to DRD3 collaboration after RD50 program terminated at the end of 2023

## EUROPEAN STRATEGY FOR PARTICLE PHYSICS DETECTOR R&D ROADMAP

In the context of the implementation of the 2020 update of the European Strategy for Particle Physics, the European Committee for Future Accelerators (ECFA) was mandated by the CERN Council in 2020 to develop a detector R&D roadmap. The 2021 ECFA Detector Research and Development Roadmap was presented to the Council at its meeting in December 2021 and the Council invited ECFA to elaborate a detailed implementation plan.

### 1 Scope of the DRD3 collaboration

The DRD3 collaboration has the dual purpose of pursuing the realization of the strategic developments outlined by the Task Force 3 (TF3) in the ECFA road map [1] and promoting blue-sky R&D in the field of solid-state detectors.





# Transfer to DRD3 collaboration after RD50 program is terminated at the end of 2023

DRD3 - Solid State Detectors  
- Research Proposal -

DRD3 Proposal Team  
September 20, 2023

## Contents

1	1	Scope of the DRD3 collaboration	3
2	1.1	The DRD3 working group structure	3
3	1.2	The DRD3 proto-collaboration	3
4	1.3	Strategic R&D	5
5	1.4	Common R&D	5
6	1.5	Institutes participation to working groups and work packages	8
7	2	WG1: Monolithic CMOS sensors	10
8	2.1	WG1 Research Goals	10
9	2.2	Technology processes	13
10	3	WG2: Sensors for tracking and calorimetry	17
11	3.1	Spatial and temporal resolutions at extreme radiation levels	17
12	3.2	Spatial and temporal resolutions at low radiation levels and low material and power budgets	17
13	3.3	WG2 Research Goals	18
14	4	WG3: Radiation damage and extreme fluence operation	19
15	4.1	Radiation damage and hardening studies at material level	19
16	4.2	Radiation damage and hardening studies at device and system levels	20
17	4.3	WG3 Research Goals	21
18	5	WG4: Simulation	22
19	5.1	Activities	22
20	5.2	WG4 Research Goals	22
21	6	WG5: Techniques, infrastructures and facilities for sensors characterisation	24
22	6.1	Working group implementation	24
23	6.2	WG5 Research Goals	25

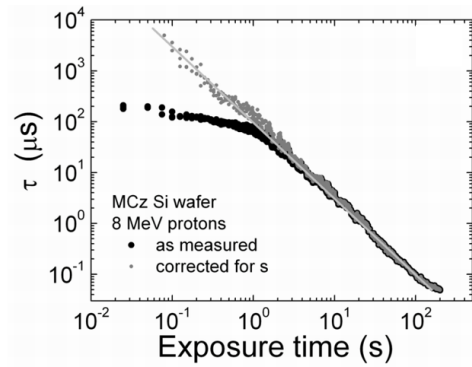
24	7	WG6: Wide bandgap and innovative sensor materials	26
25	7.1	Diamond	26
26	7.2	Wide-band semiconductor	27
27	7.3	WG6 Research Goals	27
28	8	WG7: Sensor interconnection techniques	29
29	8.1	Maskless interconnections: anisotropic conductive films or pastes (ACF, ACP)	29
30	8.2	Improvement and diffusion of classical interconnection technologies	30
31	8.3	3D and vertical integration for High Energy Physics silicon detectors	31
32	8.4	WG7 Research Goals	31
33	9	WG8: Outreach and dissemination	32
34	9.1	Disseminating knowledge on solid-state detectors to people working in high-energy physics	32
35	9.2	Disseminating knowledge on solid-state detectors to high-school students and the general public	33
36	9.3	WG8 Research Goals	33
37	10	Relationship between work packages and research goals	34
38	11	DRD3 Resources (2024 - 2026)	38
39	11.1	List of research goals	38
40	11.2	DRD3 Resources	40
41	11.3	Resources for each research goal	40
42	11.4	List of working groups	43
43	11.5	Resources for each working group	43
44	12	Path to the DRD3 collaboration	45
45	12.1	Funding for DRD3 strategic R&D	45
46	12.2	Funding for DRD3 blue-sky R&D	46
47	12.3	Funding for DRD3 operation	46
48	12.4	Funding presently available in the RD50 collaboration	46
49	13	Annex - I: List of institutions	47
50	14	Annex - II: DRD3 Proposal Team	54
51	15	Acronyms used in the proposal	55
52	16	References	57

The VU groups are anticipated to join the DRD3 collaboration with the dedicated tasks (defect spectroscopy, carrier lifetime profiling/mapping, electrical characterization of novel sensor test structures) within the following Working Groups (WG) defined in the DRD3 proposal document:

- WG2: Sensors for tracking and calorimetry;
- WG3: Radiation damage and extreme fluences;
- WG6: Wide bandgap and innovative sensor materials.

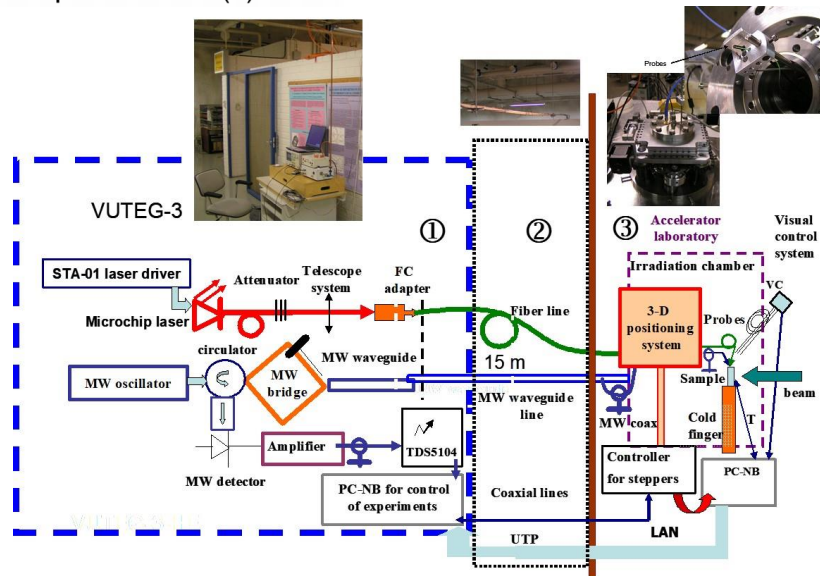
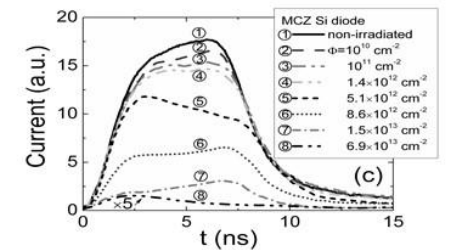
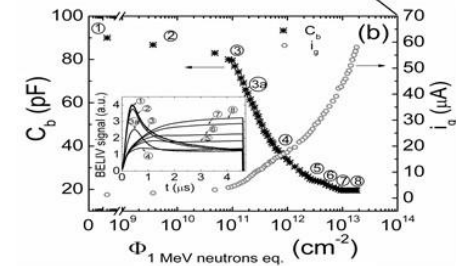
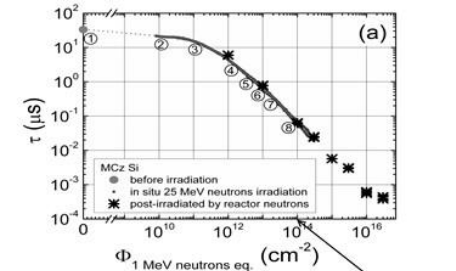
# Technologies for the in situ monitoring of evolution of radiation defects

In situ control of evolution of the radiation defects introduced by 8 MeV protons at Helsinki University accelerator laboratory.



In situ variations of carrier recombination (a- MW-PC), of barrier capacitance (b-BELIV) and of detector response (c-TCT/ICDC) during irradiation by spallator neutrons.

Correlated evolution of the MW-PC, BELIV and ICDC characteristics during spallator neutrons irradiation: transients registered every 10 ms, irradiation - bunches of 4 ns duration.



E. Gaubas, T. Ceponis, A. Jasiunas, A. Uleckas, J. Vaitkus, E. Cortina, and O. Militaru, *Correlated evolution of barrier capacitance charging, generation, and drift currents and of carrier lifetime in Si structures during 25 MeV neutrons irradiation*, Appl. Phys. Lett. **101** (2012) 232104.



# Technologies and instruments for the radiation dose and flux measurements in a wide range

- Patented method and equipment for the measurements of high cumulative doses collected under ionizing irradiations.

- Instrument and technology for dosimetry and fluxmetry of high energy electromagnetic and particle radiations.

**URKUNDE      CERTIFICATE      CERTIFICAT**

**Europäisches Patent      European patent      Brevet européen**

Es wird hiermit bescheinigt, dass für die in der Patentschrift beschriebene Erfindung ein europäisches Patent für die in der Patentschrift beschriebenen Vertragsstaaten erteilt worden ist.

It is hereby certified that a European patent has been granted in respect of the invention described in the patent specification for the Contracting States designated in the specification.

Il est certifié qu'un brevet européen a été délivré pour l'invention décrite dans le fascicule de brevet, pour les États contractants désignés dans le fascicule de brevet.

Europäisches Patent Nr. / European patent No. / Brevet européen n°: 3594723

Patentinhaber: / Proprietor(s) of the patent: / Titulaire(s) du brevet: Vilnius University / Universiteto g. 3 / 01510 Vilnius/LT

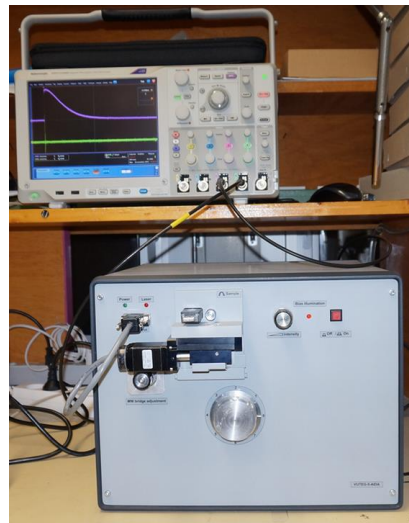
EU patent: E. Gaubas, T. Čeponis, et al, „DOUBLE RESPONSE IONIZING RADIATION DETECTOR AND MEASURING METHOD USING THE SAME“- App No.: 18213254.8, Patent No.: 3594723.

Particle identification, fluxmetry and dosimetry instrument „VUTEG-7“ (front view)

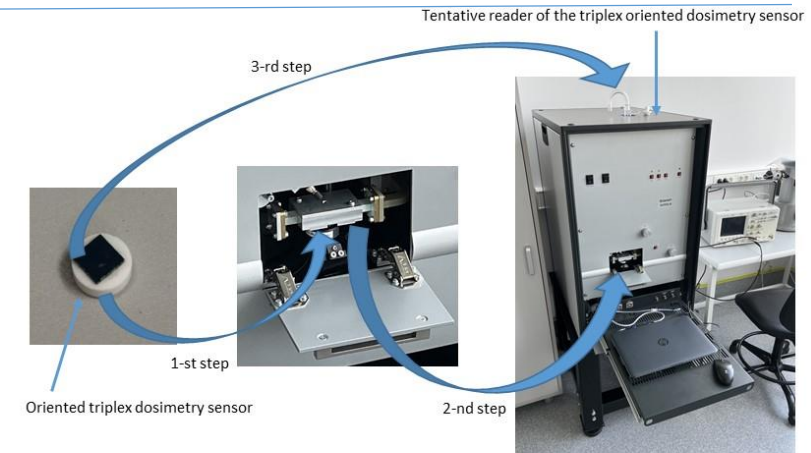


HYBRID MULTI-LAYER SENSOR AND METHOD FOR LARGE FLUENCE DOSIMETRY AND FLUXIMETRY, Authors: Eugenijus Gaubas, Tomas Čeponis, Laimonas Deveikis, Jevgenij Pavlov, Vytautas Rumbauskas. Application No. 21 165 145.0, submission date: 2021 03 26.

- Dosimeter VUTEG-5-AIDA has been installed at CERN in 2012 for the RD50 program and other CERN research. The dosimeter VUTEG-5-AIDA is devoted for dosimetric control of hot irradiation zones of large areas. This dosimeter is also equipped with precision scanning devices for evaluation of local fluence exposure. It can also be adapted for imaging of narrow irradiated beams.



- The prototype system for the control of radiation doses in a wide range. This prototype system allows measuring low and very high fluences and to identify the spectrum of high energy radiations.

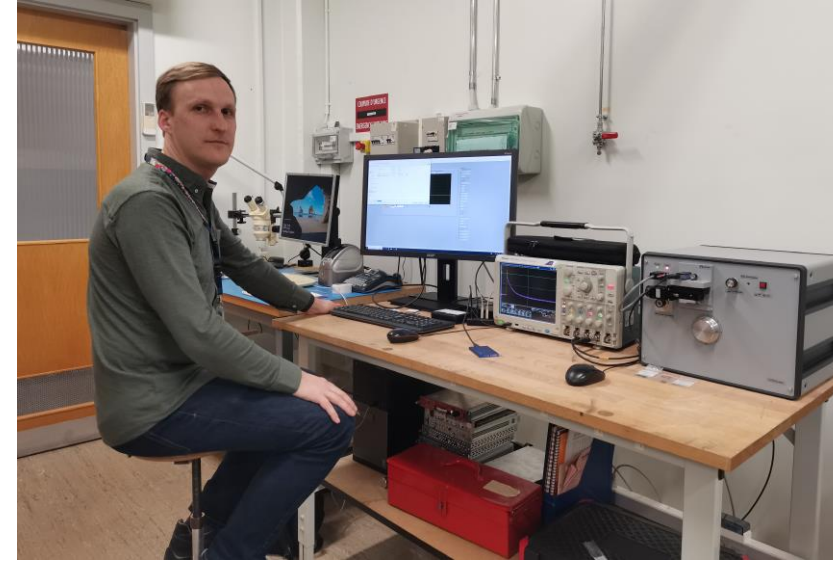
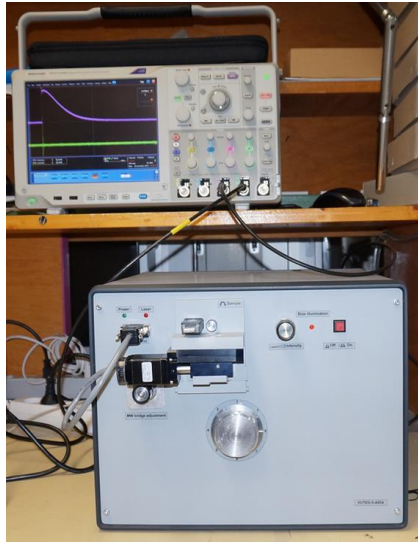


The oriented sensor is in succession set in PL as well as MW-PC opening and into the EPR insert of the tentative reader

E. Gaubas, T. Čeponis, L. Deveikis, J. Pavlov, V. Rumbauskas, Oriented triplex sensor and method of identification of the radiation source location and its dosimetry, EU patent application No. EP22171639.2, submission date: 2022 05 04.



## Multipurpose instrument VUTEG-5-AIDA installed at CERN



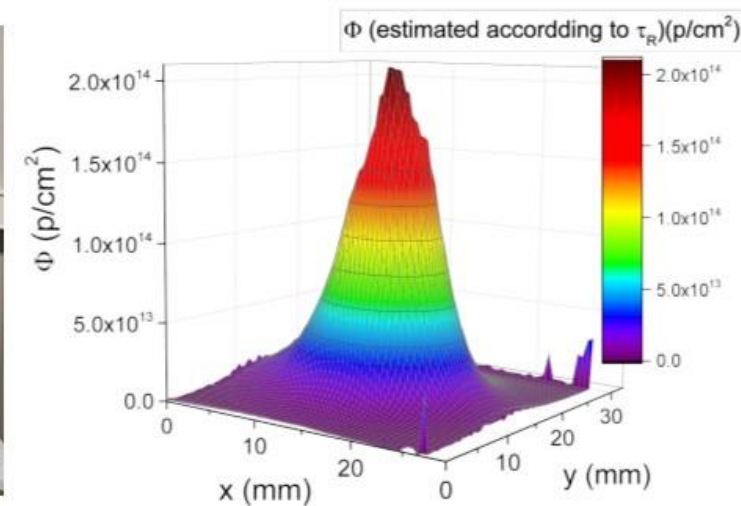
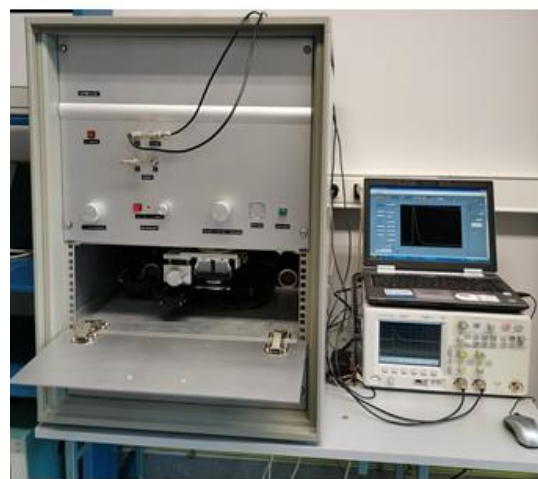
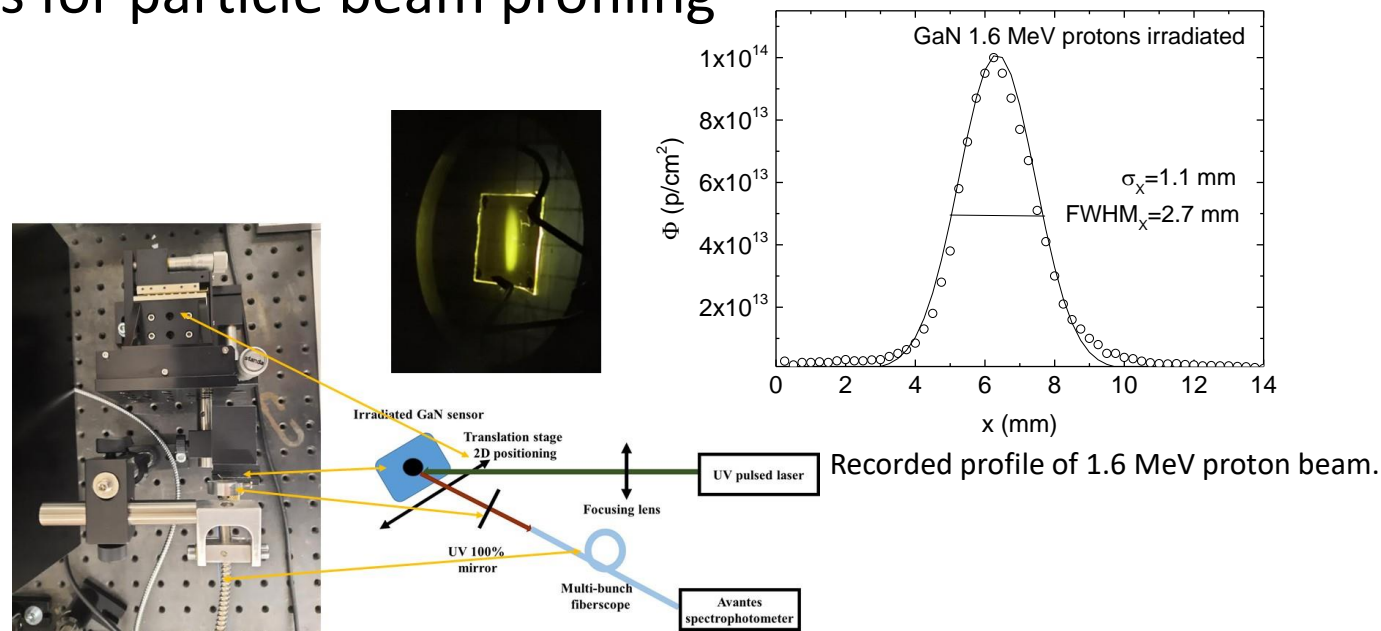
Dr. V. Rumbauskas is preparing instrument VUTEG-5-AIDA for CERN staff training in March 2023.

Instrument VUTEG-5-AIDA has been installed at CERN in 2012 for the RD50 program and other CERN research. The instrument VUTEG-5-AIDA is devoted for dosimetric control of hot irradiation zones of large areas. This dosimeter is also equipped with precision scanning devices for evaluation of local fluence exposure. It can also be adapted for imaging of narrow irradiated beams and for materials characterization.

# Technologies and instruments for particle beam profiling

The particle beam profiling techniques based on dosimetry of the hadron irradiated Si and GaN sensors have been developed. The fluence distribution profiles for high energy penetrative particles are recorded by carrier lifetime measurements within Si wafer. For beams of rather low energy particles, sensors with thin active layers are preferable. Then, the scintillation techniques are eligible to have recordable responses from thin sensor layers.

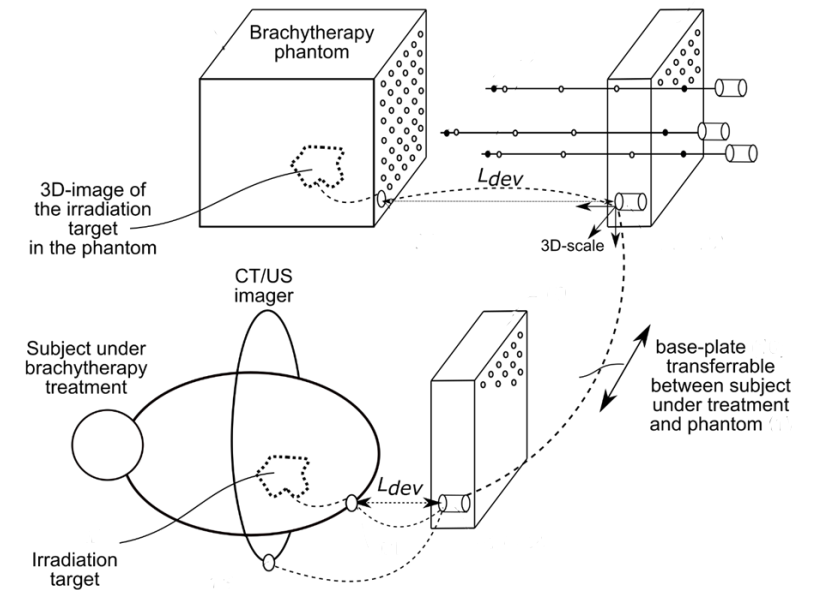
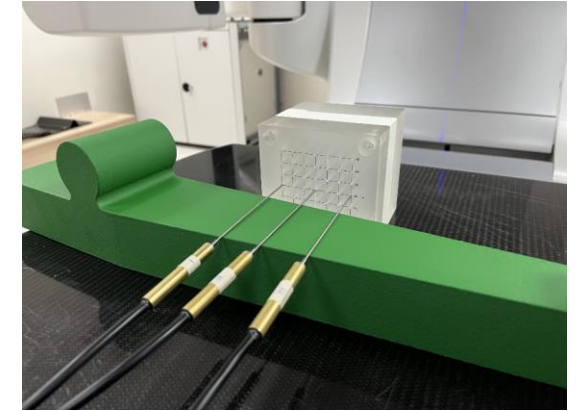
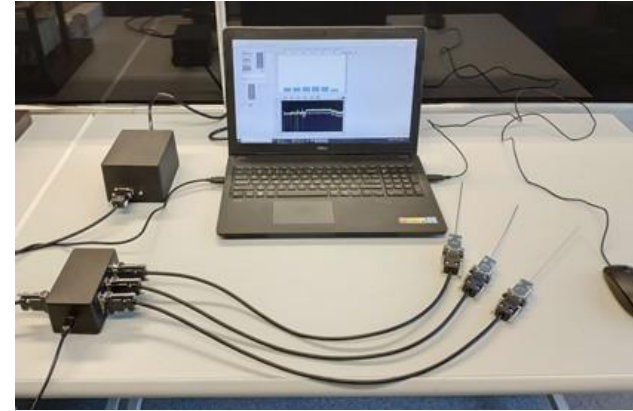
- L. Deveikis, J.V. Vaitkus, T. Čeponis, M. Gaspariūnas, V. Kovalevskij, V. Rumbauskas, E. Gaubas, *Profiling of proton beams by fluence scanners*, Lith. J. Phys. **61** (2021) 75–83.
- T. Ceponis, L. Deveikis, E. Gaubas V. Rumbauskas, M. Moll, Particle beam profilers based on fluence dependent variations of carrier lifetime and scintillation intensity in Si and GaN materials, Presentation at RD50 workshop, CERN 2022-06.





# Radiation dose monitoring systems for medical applications

- Development of technology and instrumentation for time-resolved positioning of radiation emitters and for dosimetry during the brachytherapy planning and a subsequent in vivo brachytherapy treatment stages, where the method and apparatus are based on triangulation of needle-type probes fixed within time-space resolved coordinates.
- The technology and instrumentation have been approved at The National Cancer Institute (Lithuania).
- In vivo tests of radiation dose monitoring during brachytherapy therapeutic procedure are being performed at National Cancer Institute (Lithuania) since October 2022.



E. Gaubas, T. Čeponis, K. Pūkas, V. Rumbauskas, M. Užgirytė, J. Venius, K. Akelaitis, A. Cicinas. SYSTEM AND METHOD FOR BRACHYTHERAPY PROCEDURE PLANNING AND VERIFICATION, EU patent application No. EP21210650.4, submission date: 2021 11 26.



## Main achievements during 2022-2023 years (1)

### List of scientific publications related with CERN activities:

1. J. Pavlov, T. Ceponis, K. Pukas, L. Makarenko, E. Gaubas, *5.5 MeV electron irradiation-induced transformation of minority carrier traps in p-type Si and Si<sub>1-x</sub>Ge<sub>x</sub> alloys*, *Materials* **15** (2022) 1861.
2. T. Ceponis, J. Pavlov, A. Kadys, A. Vaitkevicius, E. Gaubas, *Luminescence characteristics of the MOCVD GaN structures with chemically etched surfaces*, *Materials* **16** (2023) 3424.
3. T. Ceponis, M. Burkanas, A. Cicinas, L. Deveikis, J. Pavlov, V. Rumbauskas, J. Venius, E. Gaubas, *Combined techniques for recovery of radiation damaged detectors*, accepted for publication in *Mat. Sc. Sem. Proc. journal*.

(19 during 2018-2023)

### List of patents and patent applications:

1. Lithuanian patent – E. Gaubas, T. Čeponis, V. Kalesinskas, V. Rumbauskas, L. Deveikis „Magnetinis reliatyvistinių elektringųjų dalelių analizatorius“ (*Magnetic analyzer for relativistic charged particles*), Patent No. 6929, date of publication 2022-08-10.
2. Lithuanian patent - E. Gaubas, T. Čeponis, L. Deveikis, J. Pavlov, V. Rumbauskas „Hibridinis daugiasluoksnis jutiklis ir didelių įtėkių bei srautų matavimo metodas“ (*Hybrid multi-layer sensor and method for large fluence dosimetry and fluxmetry*), Patent No. 6931, date of publication 2022-08-10.
3. European patent application – E. Gaubas, T. Čeponis, L. Deveikis, J. Pavlov, V. Rumbauskas, „Oriented triplex sensor and method of identification of the radiation source location and its dosimetry“, Application No. EP22171639.2, submission date: 2022 05 04.

(8 during 2018-2023)

### Presentations at conferences:

- 5 during 2022-2023;

(9 during 2018-2023)





## Main achievements during 2022-2023 years (2)

### Implemented projects:

1. LMT „SMART“ project 01.2.2.-LMT-K-718-01-0013 „Creation of the prototype wide-spectrum dosimetry system for various purpose monitoring of irradiations“, 600000 EUR/2018-2022 yr.
2. Lithuanian Academy of Science project CERN-VU-2022-4 „Radiation tolerant semiconductor detectors for high luminosity colliders“, 33700 EUR/2022 yr.

(7 during 2018-2023, overall budget >2 mln. EUR)

### List of dended PHD thesis in the field related with CERN activities:

1. L. Deveikis, Electrically active defects and their transformations in GaN structures, thesis defended in 2022 yr.
2. K. Pūkas, Technologies of dosimetry in applications of high energy physics and radiation medicine, thesis defended in 2022 yr.

(3 during 2018-2023)

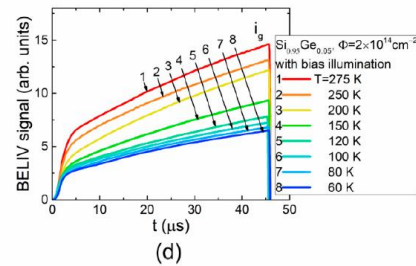
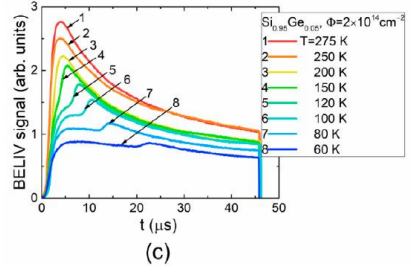
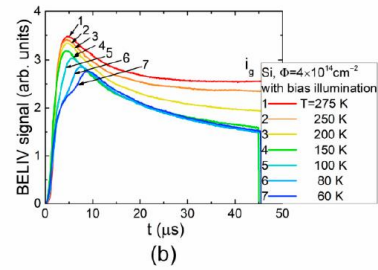
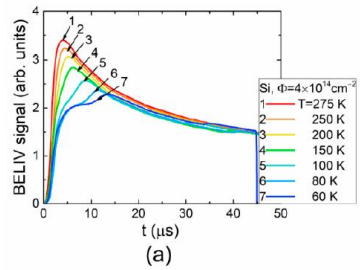
### Rewards:

In 2022 T. Ceponis, E. Gaubas, J. Vaitkus received the Lithuanian National Science Prize for the cycle of work on “Study of impact of high radiation fluences on matter for development of dosimetry and radiation technologies (2006-2020)”.

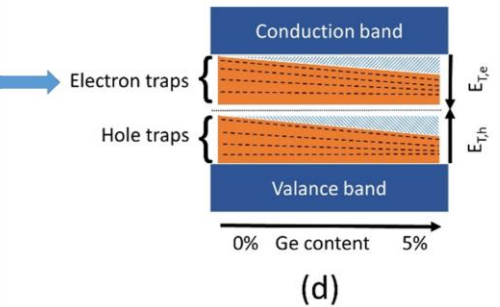
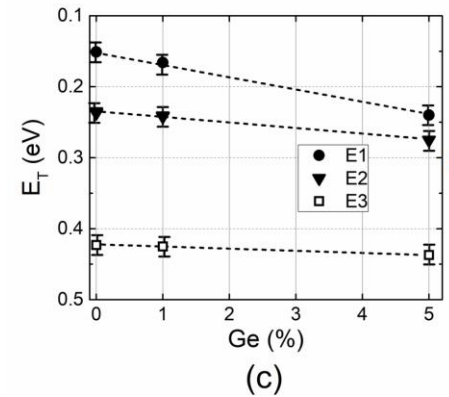
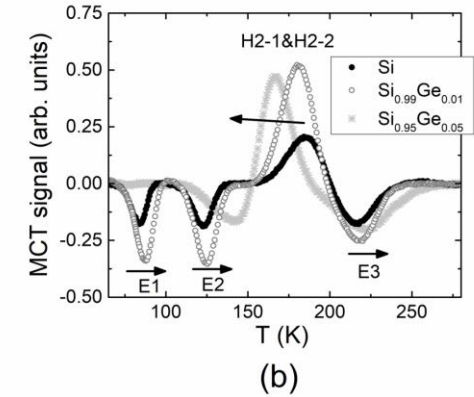
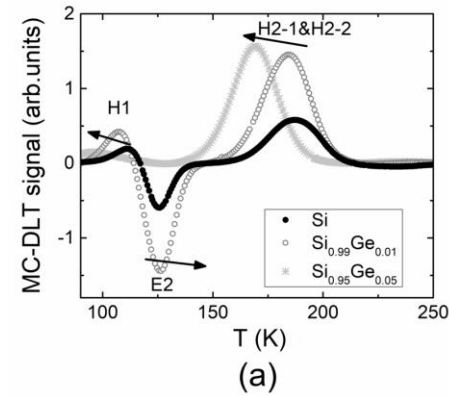


*Thank you for your attention*

# Spectroscopy of defects in irradiated sensors

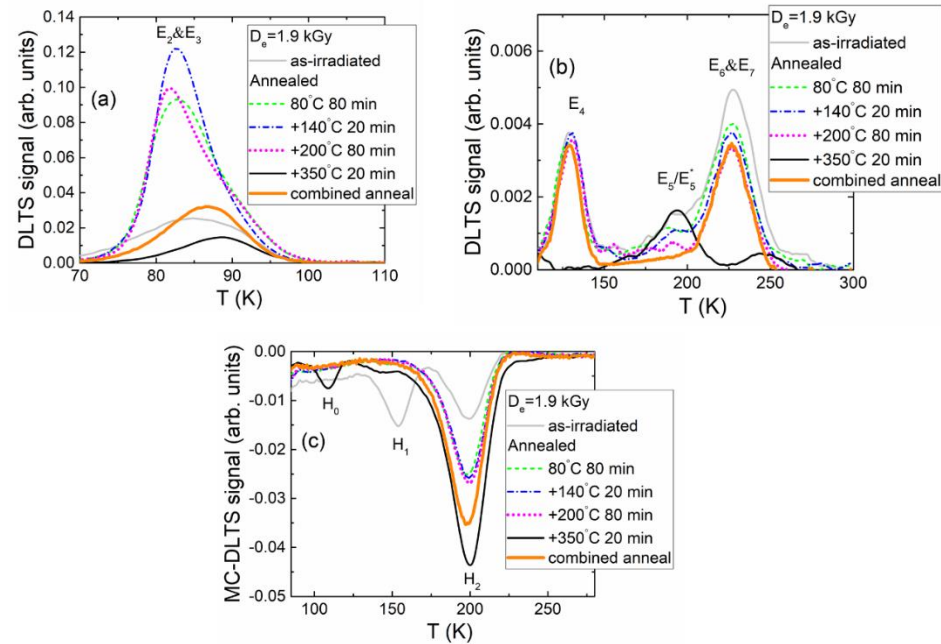


Temperature-dependent BELIV transients in Si and  $\text{Si}_{1-x}\text{Ge}_x$  diodes measured in dark (a,c) and under (b,d) laser illumination.

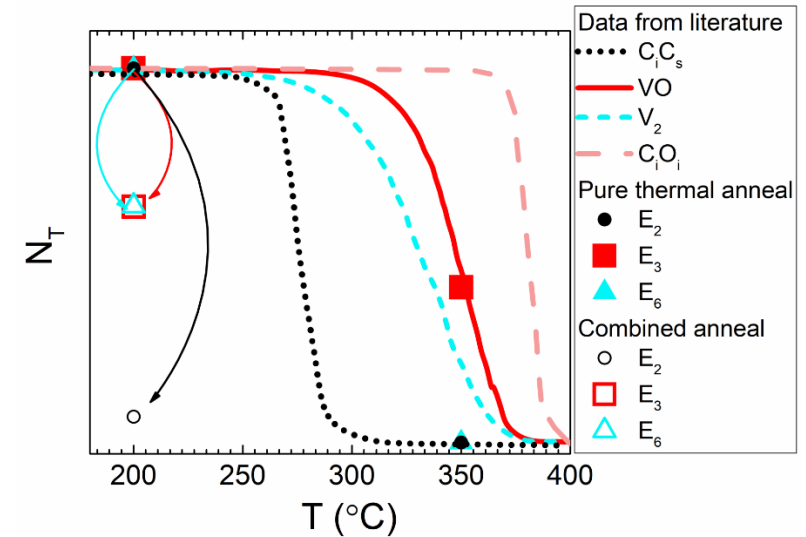


Comparison of MC-DLT (a) and MCT (b) spectra obtained in the 5.5 MeV electron-irradiated Si,  $\text{Si}_{0.99}\text{Ge}_{0.01}$  and  $\text{Si}_{0.95}\text{Ge}_{0.05}$  diodes; (c) The activation energy values ( $E_T$ ) of the radiation-induced traps (E1–E3) of minority carriers as a function of Ge content; (d) A tentative scheme of the band gap variation in p-type  $\text{Si}_{1-x}\text{Ge}_x$  material and related activation energy changes in the minority carrier traps depending on the Ge content.

# Techniques for recovery of radiation damaged detectors



Thermal processing regime dependent variations of the deep-level transient (DLT) spectra of majority (a) and (b) and minority (c) carrier traps recorded on the pristine and electron irradiated Si PIN diodes.



Temperature ranges (according to literature data) where various carrier traps in Si materials can be isochronally 15-30 min annealed out (solid curves) are compared with the data obtained in this work using pure thermal (solid symbols) and combined furnace-laser (open symbols) anneal technology. It can be seen that the combined anneal leads to more efficient transformations of defects when compared with the pure thermal anneals by reaching the same temperature  $T_{furnace}$ .